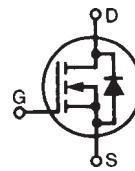


TrenchMV™ Power MOSFET

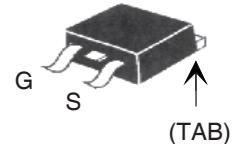
IXTA130N10T IXTP130N10T

N-Channel Enhancement Mode
Avalanche Rated

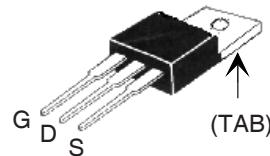


V_{DSS} = 100V
 I_{D25} = 130A
 $R_{DS(on)}$ ≤ 9.1mΩ

TO-263 (IXTA)



TO-220 (IXTP)



G = Gate D = Drain
 S = Source TAB = Drain

Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ\text{C}$ to 175°C	100		V
V_{DGR}	$T_J = 25^\circ\text{C}$ to 175°C , $R_{GS} = 1\text{M}\Omega$	100		V
V_{GSM}	Transient	± 30		V
I_{D25}	$T_C = 25^\circ\text{C}$	130		A
I_{LRMS}	Lead Current Limit, RMS	75		A
I_{DM}	$T_C = 25^\circ\text{C}$, pulse width limited by T_{JM}	350		A
I_A	$T_C = 25^\circ\text{C}$	65		A
E_{AS}	$T_C = 25^\circ\text{C}$	500		mJ
P_D	$T_C = 25^\circ\text{C}$	360		W
T_J		-55 ... +175		°C
T_{JM}		175		°C
T_{stg}		-55 ... +175		°C
T_L	1.6mm (0.062 in.) from case for 10s	300		°C
T_{SOLD}	Plastic body for 10 seconds	260		°C
M_d	Mounting torque (TO-220)	1.13 / 10		Nm/lb.in.
Weight	TO-220	3.0		g
	TO-263	2.5		g

Symbol	Test Conditions	Characteristic Values		
	($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
BV_{DSS}	$V_{GS} = 0\text{V}$, $I_D = 250\mu\text{A}$	100		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$	2.5		V
I_{GSS}	$V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$		± 200	nA
I_{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0\text{V}$		5 250	μA
$R_{DS(on)}$	$V_{GS} = 10\text{V}$, $I_D = 25\text{A}$, Notes 1, 2		9.1	$\text{m}\Omega$

Features

- Ultra-low On Resistance
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
 - easy to drive and to protect
- 175 °C Operating Temperature

Advantages

- Easy to mount
- Space savings
- High power density

Applications

- Automotive
 - Motor Drives
 - 42V Power Bus
 - ABS Systems
- DC/DC Converters and Off-line UPS
- Primary Switch for 24V and 48V Systems
- Distributed Power Architectures and VRMs
- Electronic Valve Train Systems
- High Current Switching Applications
- High Voltage Synchronous Rectifier

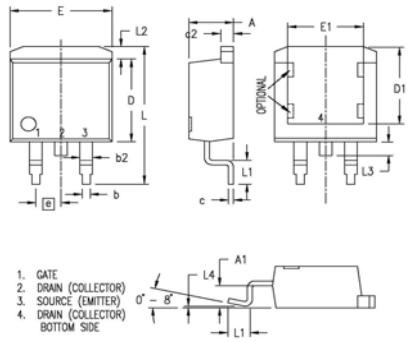
Symbol	Test Conditions	Characteristic Values		
	($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
g_{fs}	$V_{DS} = 10\text{V}$, $I_D = 60\text{A}$, Note 1	55	93	S
C_{iss} C_{oss} C_{rss}	$V_{GS} = 0\text{V}$, $V_{DS} = 25\text{V}$, $f = 1\text{MHz}$	5080	pF	
		635	pF	
		95	pF	
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	Resistive Switching Times $V_{GS} = 10\text{V}$, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 25\text{A}$ $R_G = 5\Omega$ (External)	30	ns	
		47	ns	
		44	ns	
		28	ns	
$Q_{g(on)}$ Q_{gs} Q_{gd}	$V_{GS} = 10\text{V}$, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 25\text{A}$	104	nC	
		30	nC	
		29	nC	
R_{thJC}			0.42	$^\circ\text{C}/\text{W}$
R_{thCH}	TO-220	0.50		$^\circ\text{C}/\text{W}$

Source-Drain Diode

Symbol	Test Conditions	Characteristic Values		
	$T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
I_s	$V_{GS} = 0\text{V}$		130	A
I_{SM}	Pulse width limited by T_{JM}		350	A
V_{SD}	$I_F = 25\text{A}$, $V_{GS} = 0\text{V}$, Note 1		1.0	V
t_{rr} I_{RM} Q_{rr}	$I_F = 0.5 \cdot I_s$, $-\frac{dI}{dt} = 100\text{A}/\mu\text{s}$ $V_R = 0.5 \cdot V_{DSS}$, $V_{GS} = 0\text{V}$	67	ns	
		4.7	A	
		160	nC	

Notes: 1. Pulse test, $t \leq 300 \mu\text{s}$; duty cycle, $d \leq 2\%$.
 2. On through-hole packages, $R_{DS(on)}$ Kelvin test contact location must be 5 mm or less from the package body.

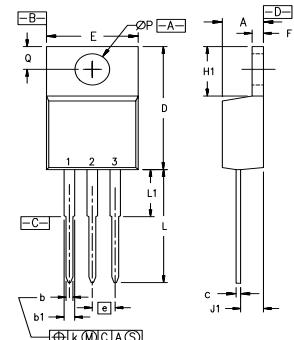
TO-263 (IXTA) Outline



Pins: 1 - Gate 2 - Drain
3 - Source 4, TAB - Drain

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.06	4.83	.160	.190
A1	2.03	2.79	.080	.110
b	0.51	0.99	.020	.039
b2	1.14	1.40	.045	.055
c	0.46	0.74	.018	.029
c2	1.14	1.40	.045	.055
D	8.64	9.65	.340	.380
D1	7.11	8.13	.280	.320
E	9.65	10.29	.380	.405
E1	6.86	8.13	.270	.320
e	2.54	BSC	.100	BSC
L	14.61	15.88	.575	.625
L1	2.29	2.79	.090	.110
L2	1.02	1.40	.040	.055
L3	1.27	1.78	.050	.070
L4	0	0.38	0	.015
R	0.46	0.74	.018	.029

TO-220 (IXTP) Outline



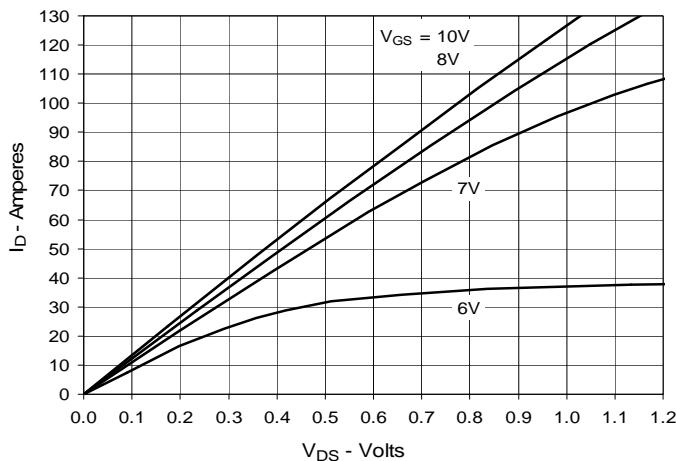
Pins: 1 - Gate 2 - Drain
3 - Source 4, TAB - Drain

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.170	.190	4.32	4.83
b	.025	.040	0.64	1.02
b1	.045	.065	1.15	1.65
c	.014	.022	0.35	0.56
D	.580	.630	14.73	16.00
E	.390	.420	9.91	10.66
e	.100	BSC	2.54	BSC
F	.045	.055	1.14	1.40
H1	.230	.270	5.85	6.85
J1	.090	.110	2.29	2.79
k	0	.015	0	0.38
L	.500	.550	12.70	13.97
L1	.110	.230	2.79	5.84
ØP	.139	.161	3.53	4.08
Q	.100	.125	2.54	3.18

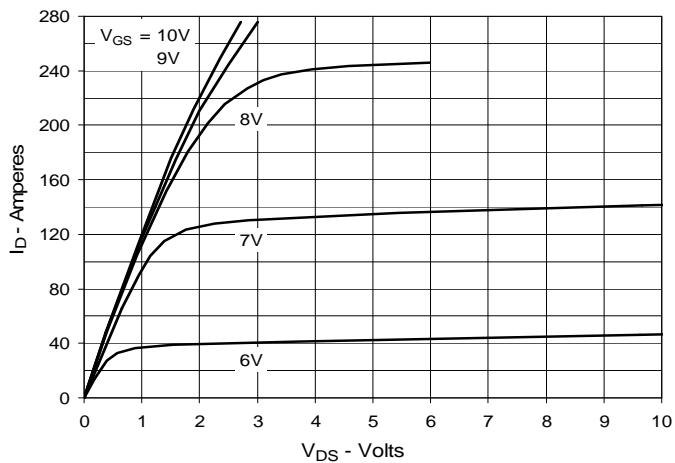
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

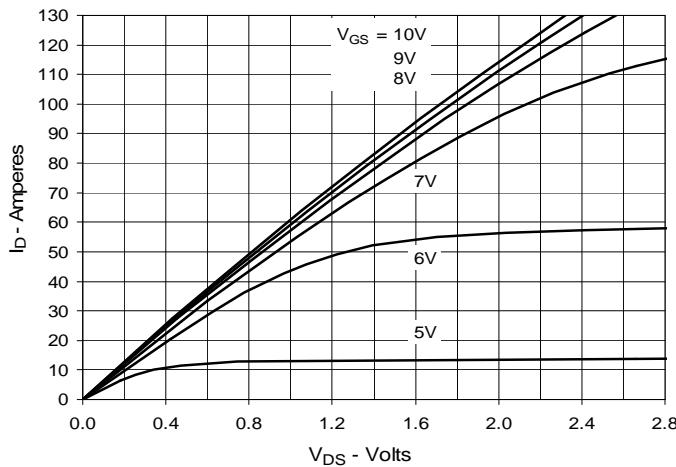
**Fig. 1. Output Characteristics
@ 25°C**



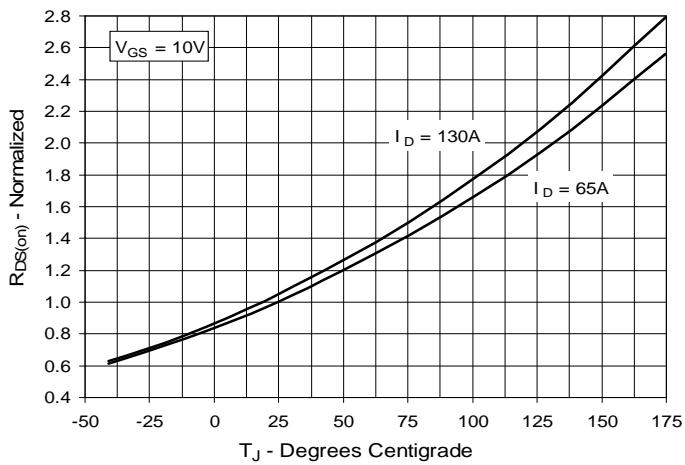
**Fig. 2. Extended Output Characteristics
@ 25°C**



**Fig. 3. Output Characteristics
@ 150°C**



**Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 65A$ Value
vs. Junction Temperature**



**Fig. 5. $R_{DS(on)}$ Normalized to $I_D = 65A$ Value
vs. Drain Current**

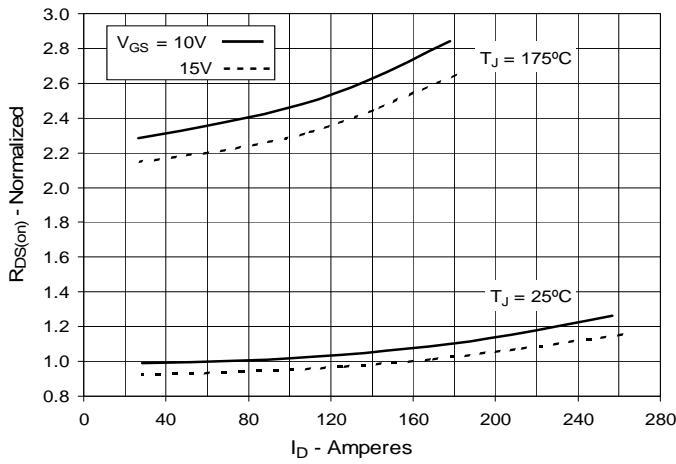


Fig. 6. Drain Current vs. Case Temperature

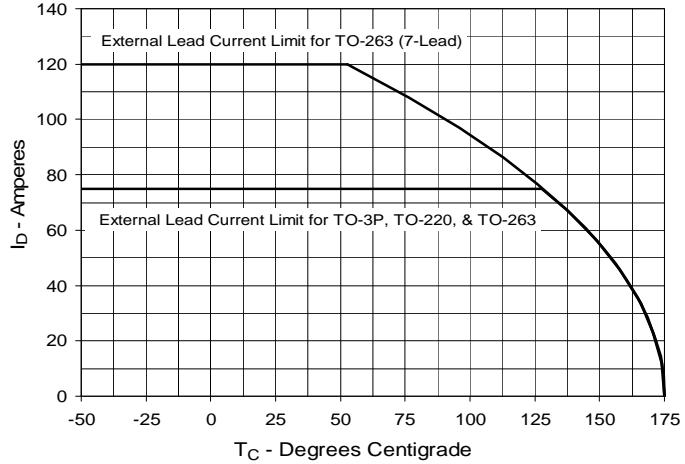
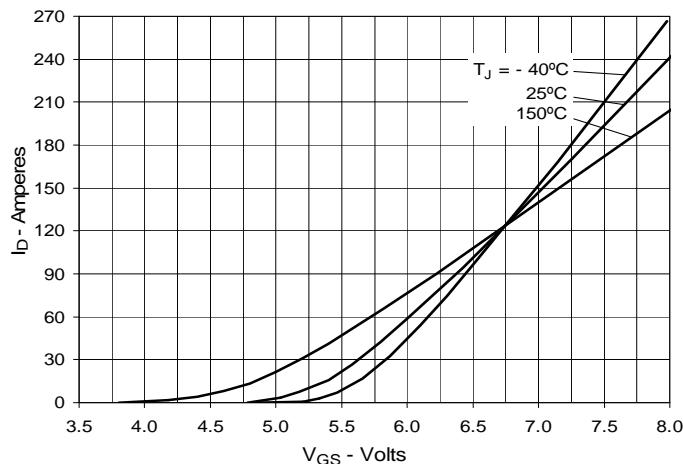
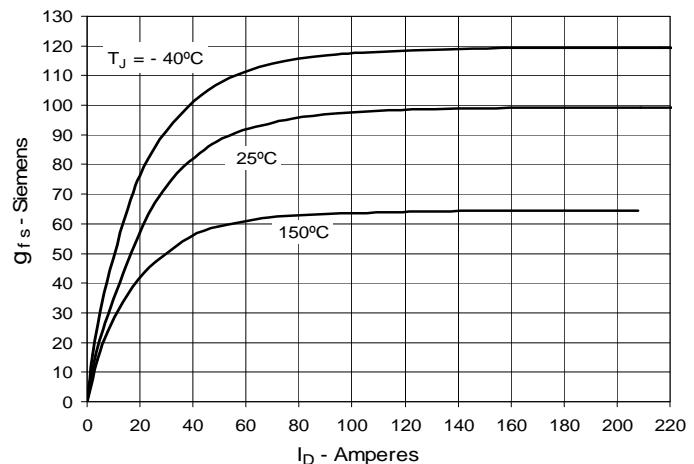
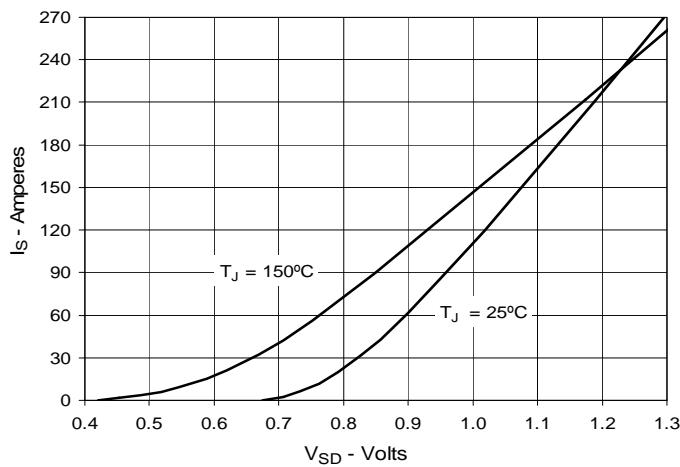
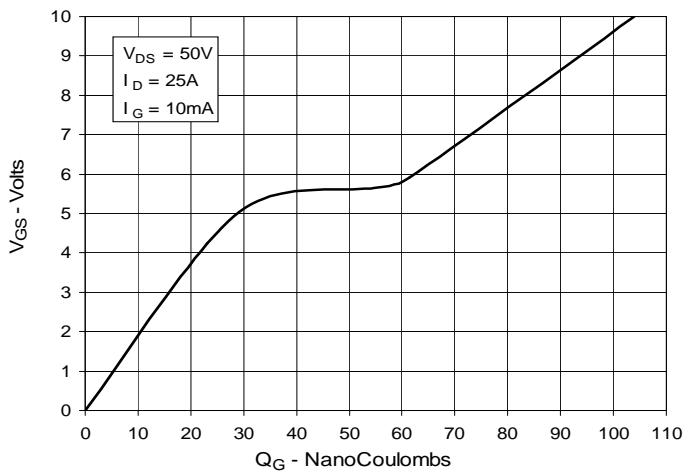
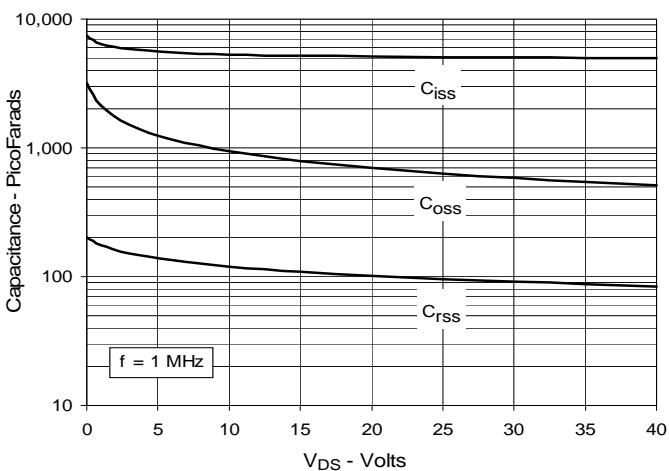
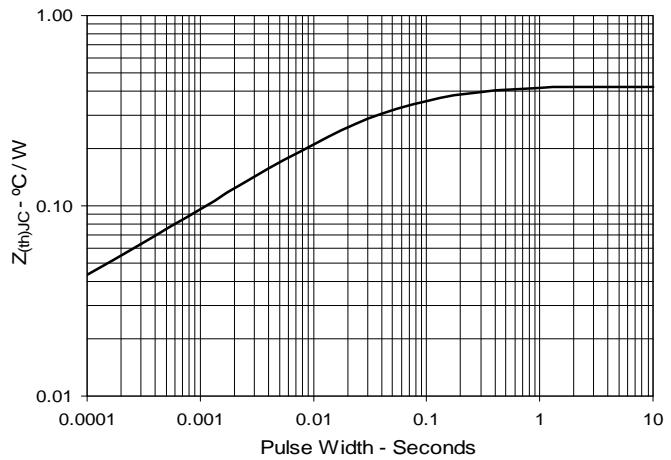
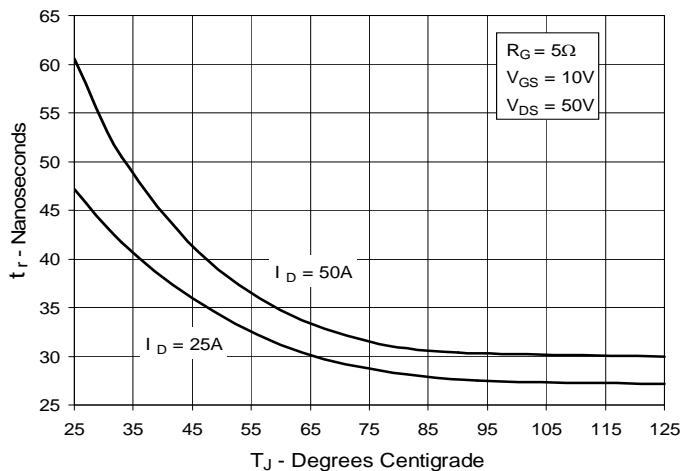
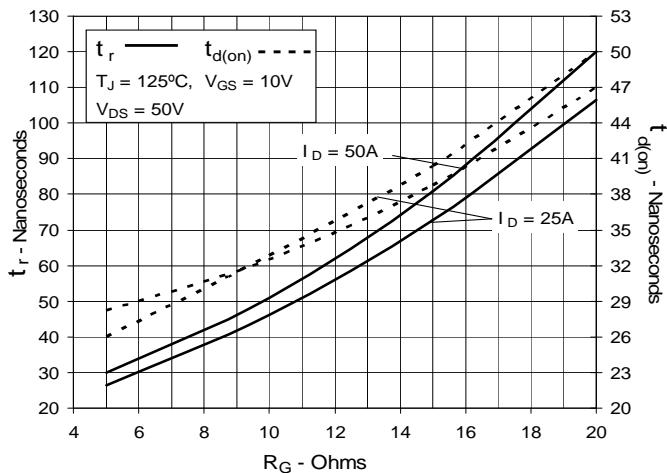


Fig. 7. Input Admittance

Fig. 8. Transconductance

Fig. 9. Forward Voltage Drop of Intrinsic Diode

Fig. 10. Gate Charge

Fig. 11. Capacitance

Fig. 12. Maximum Transient Thermal Impedance


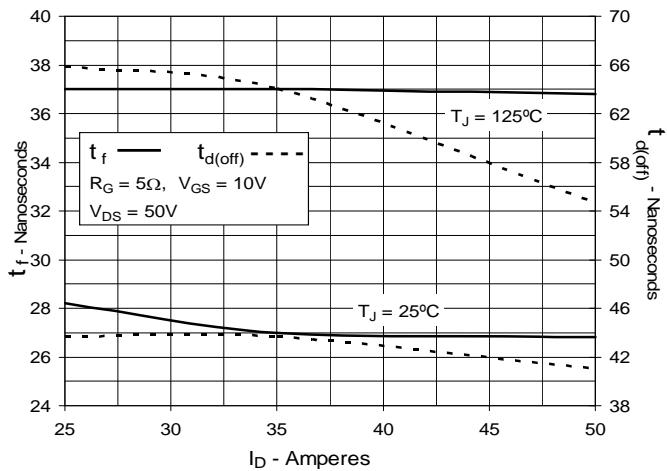
**Fig. 13. Resistive Turn-on
Rise Time vs. Junction Temperature**



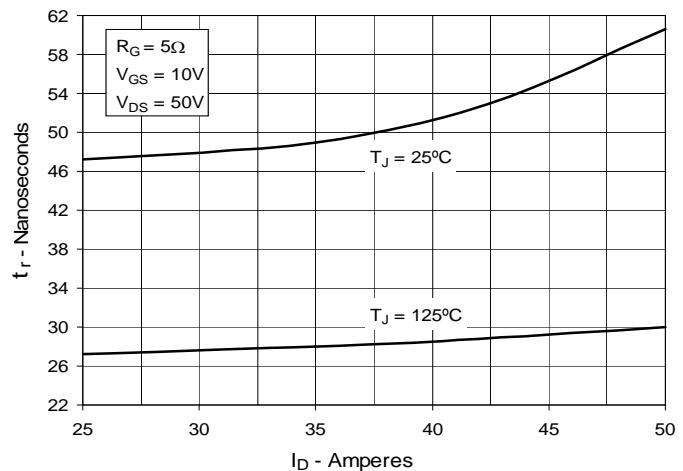
**Fig. 15. Resistive Turn-on
Switching Times vs. Gate Resistance**



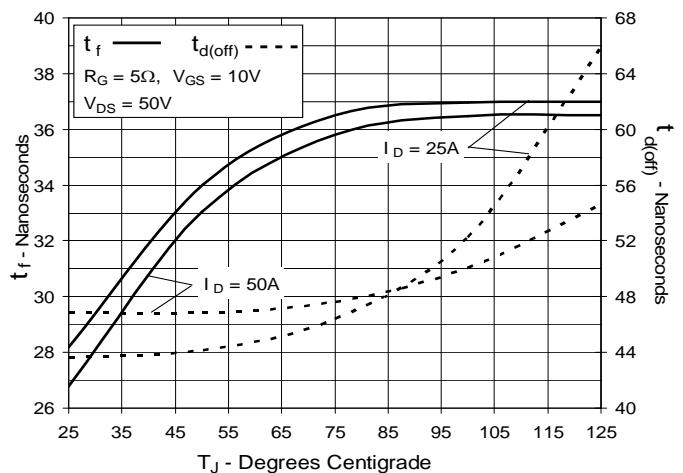
**Fig. 17. Resistive Turn-off
Switching Times vs. Drain Current**



**Fig. 14. Resistive Turn-on
Rise Time vs. Drain Current**



**Fig. 16. Resistive Turn-off
Switching Times vs. Junction Temperature**



**Fig. 18. Resistive Turn-off
Switching Times vs. Gate Resistance**

